

SED5852B

P-Channel Enhancement Mode Field Effect Transistor with Schottky Diode

General Description

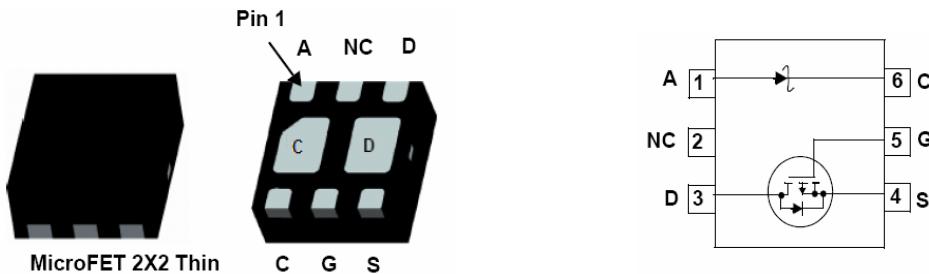
The SED5852 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. A Schottky diode is provided to facilitate the implementation of a bidirectional blocking switch, or for DC-DC conversion applications. Standard Product SED5852 is Pb-free (meets ROHS specifications).

Features

$V_{DS(V)} = -20V$
 $I_D = -3.4A$ ($V_{GS} = -4.5V$)
 $R_{DS(ON)} < 140m\Omega$ ($V_{GS} = -4.5V$)
 $R_{DS(ON)} < 200m\Omega$ ($V_{GS} = -2.5V$)

SCHOTTKY

$V_{DS(V)} = 20V$, $I_F = 1A$, $V_F < 0.5V @ 0.5A$



Absolute maximum ratings ($T_a=25^\circ C$)

Parameter	Symbol	MOSFET	Schottky	Unit
Drain-Source Voltage	V_{DS}	-20		V
Gate-Source Voltage	V_{GS}	± 8		V
Continuous Drain Current ^A	I_D	-2.3		A
$T_A = 70^\circ C$		-1.9		
Pulsed Drain Current ^B	I_{DM}	-15		
Schottky reverse voltage	V_{KA}		20	V
Continuous Forward Current ^A	I_F		1.9	A
$T_A = 70^\circ C$		1.2		
Pulsed Forward Current ^B	I_{FM}		7	
Power Dissipation	P_D	1.7	0.96	W
$T_A = 70^\circ C$		1.1	0.62	
Junction and Storage Temperature Range	I_J , I_{STG}	-55 to 150	-55 to 150	°C

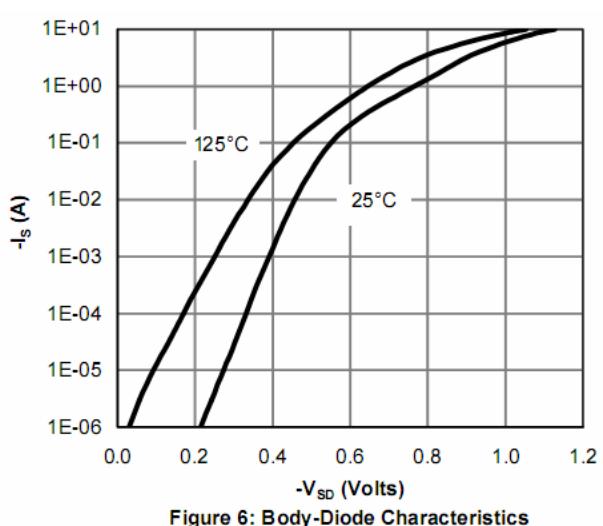
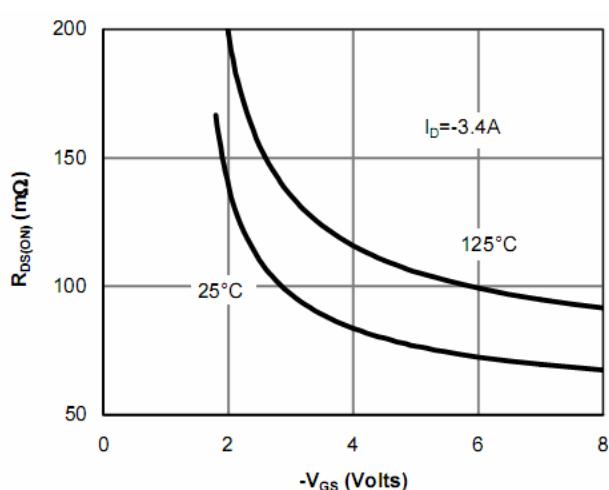
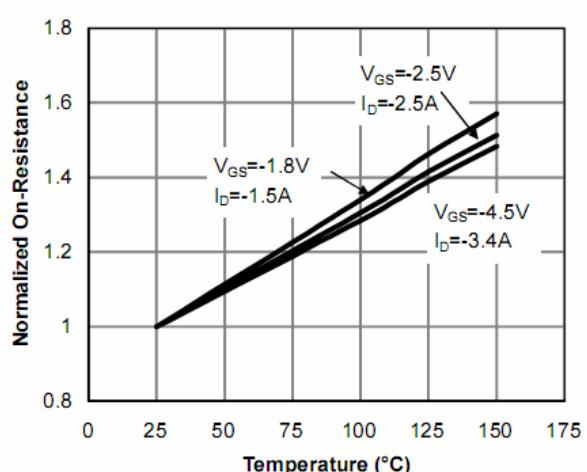
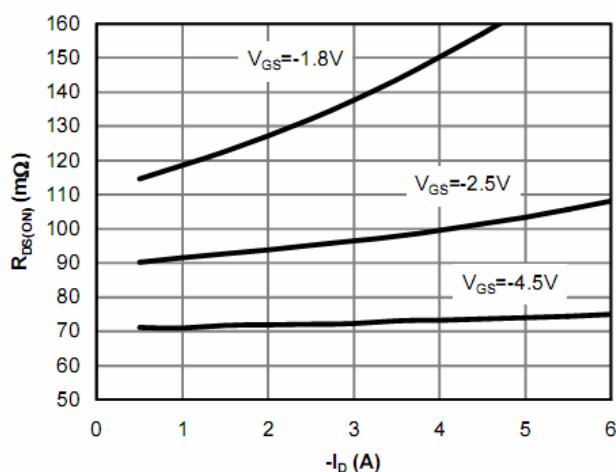
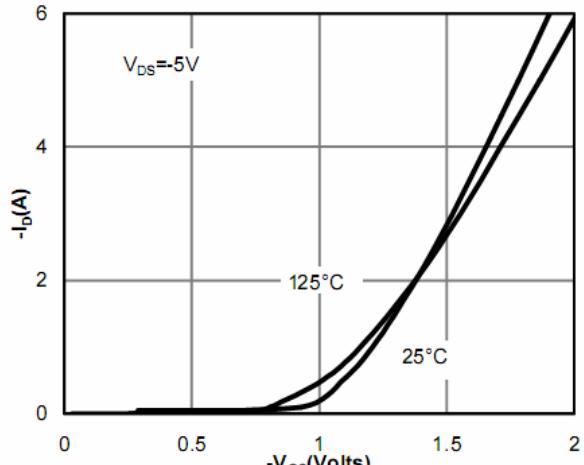
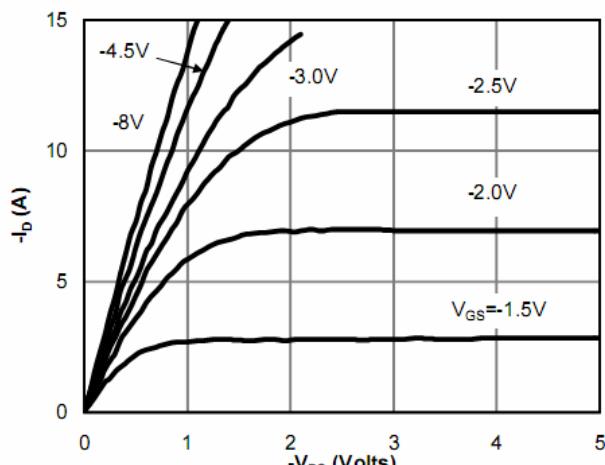
Parameter: Thermal Characteristics MOSFET	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	51	75	°C/W
Maximum Junction-to-Ambient ^A		88	110	
Maximum Junction-to-Lead ^C	$R_{\theta JL}$	28	35	

Thermal Characteristics Schottky

Maximum Junction-to-Ambient ^A	$t \leq 10s$	$R_{\theta JA}$	66	80	°C/W
Maximum Junction-to-Ambient ^A	Steady-State		95	130	
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	40	50	

Electrical Characteristics ($T_J=25^\circ C$ unless otherwise note)						
Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = -250\mu A, V_{GS}=0V$	-20			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16V, V_{GS}=0V$			-1	μA
		$V_{DS} = -16V, V_{GS}=0V (T_J=55^\circ C)$			-5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 8V$			± 100	nA
$V_{GS(IN)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D = -250\mu A$	-0.3	-0.63	-1	V
$I_{D(ON)}$	On state drain current	$V_{GS} = -4.5V, V_{DS}=-5V$	-15			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=-4.5V, I_D = -2.0A$		120	140	$m\Omega$
		$V_{GS} = -2.5V, I_D = -2.0A$		180	200	$m\Omega$
g_{FS}	Forward Transconductance	$V_{GS} = -5V, I_D = -2.0A$	4	7		S
V_{SD}	Diode Forward Voltage	$V_{GS} = 0V, I_S = -1A$		-0.83	-1	V
I_S	Maximum Body-Diode Continuous Current				-2	A
DYNAMIC PARAMETERS						
C_{ISS}	Input Capacitance	$V_{GS} = 0V, V_{DS} = -10V, f = 1MHz$		540		pF
C_{OSS}	Output Capacitance			72		pF
C_{RSS}	Reverse Transfer Capacitance			49		pF
R_g	Gate resistance	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		12		Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS} = -4.5V, V_{DS} = -10V, I_D = -3.4A$		6.1		nC
Q_{gs}	Gate Source Charge			0.6		nC
Q_{gd}	Gate Drain Charge			16		nC
$T_{D(on)}$	Turn-On Delay Time	$V_{GS} = -4.5V, V_{DS} = -10V, R_L = 2.9\Omega, R_{GEN} = 3\Omega$		10		ns
t_r	Turn-On Rise Time			12		ns
$T_{D(off)}$	Turn-Off Delay Time			44		ns
t_f	Turn-Off Fall Time			22		ns
t_{rr}	Reverse Recovery Time	$I_F = -3.4A, dI/dt = 100A/\mu s$		21		ns
Q_{rr}	Reverse Recovery Charge	$I_F = -3.4A, dI/dt = 100A/\mu s$		7.5		nC
SCHOTTKY PARAMETERS						
V_F	Forward Voltage Drop	$I_F = 0.5A$		0.39	0.5	V
I_{rm}	Maximum reverse leakage current	$V_R = 16V$			0.05	mA
		$V_R = 16V, T_J = 125^\circ C$			10	
C_T	Junction Capacitance	$V_R = 10V$		34		pF
t_{rr}	Schottky Reverse Recovery Time	$I_F = 1A, dI/dt = 100A/\mu s$		5.2	10	Ns
Q_{rr}	Schottky Reverse Recovery Charge	$I_F = 1A, dI/dt = 100A/\mu s$		0.8		nC

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



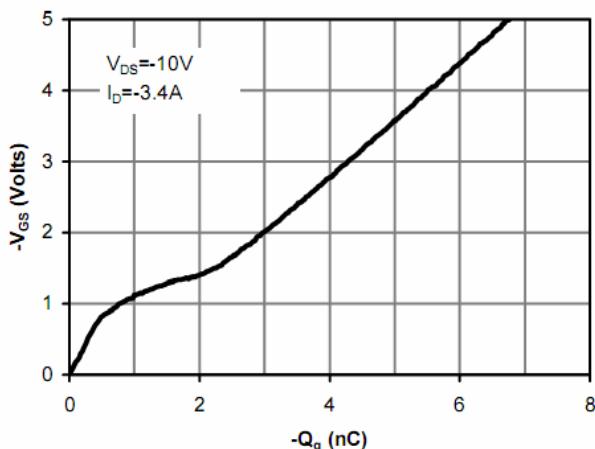


Figure 7: Gate-Charge Characteristics

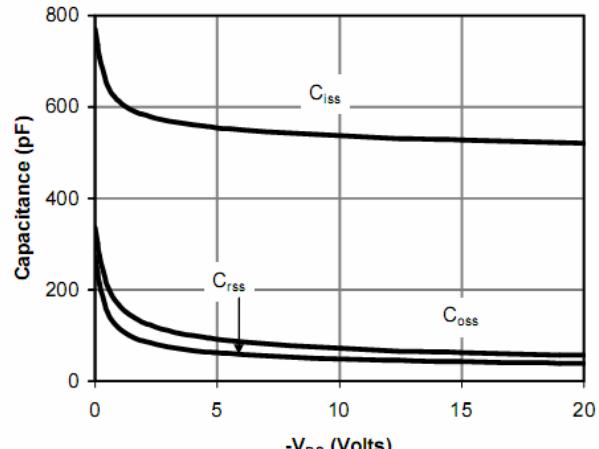


Figure 8: Capacitance Characteristics

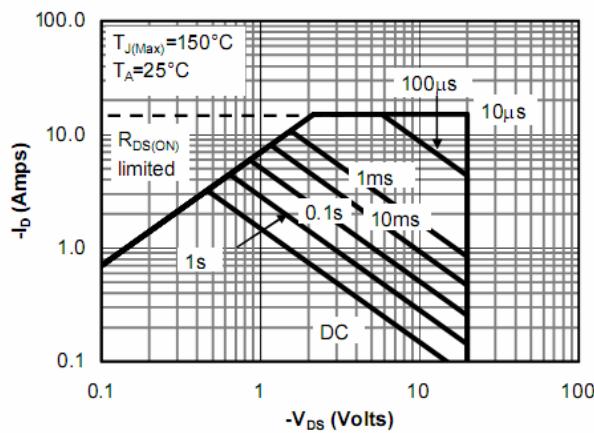


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

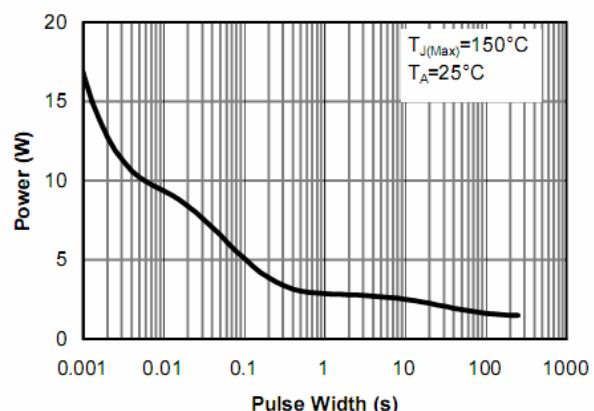


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

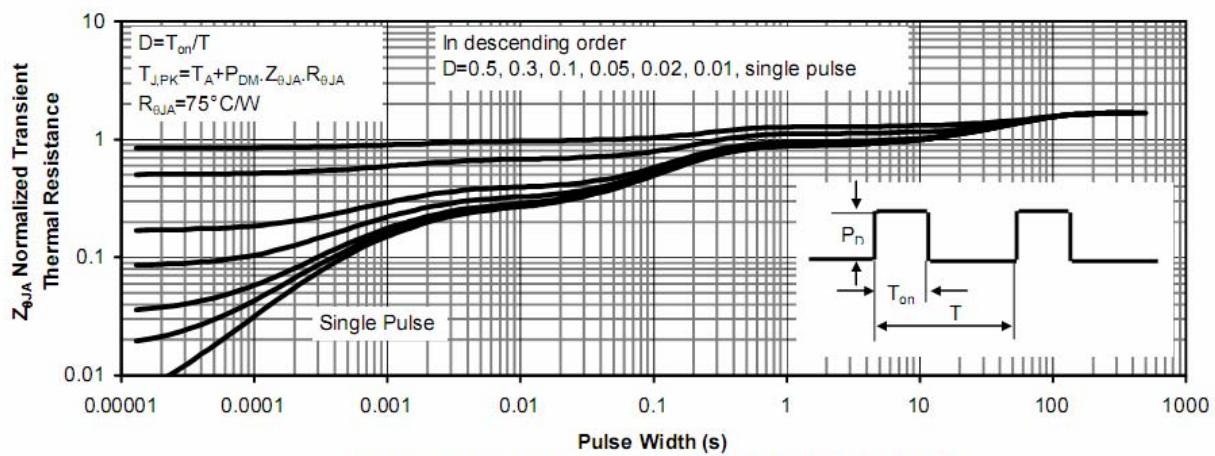


Figure 11: Normalized Maximum Transient Thermal Impedance

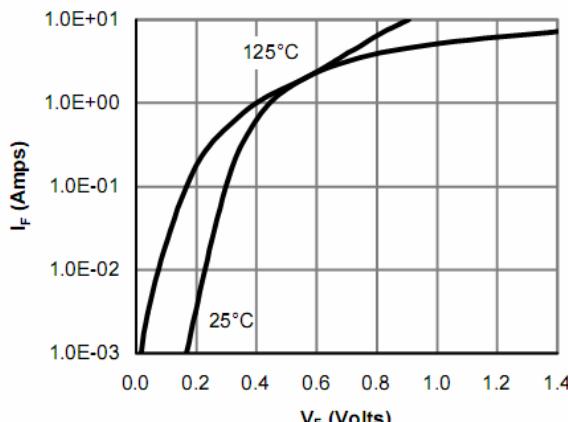


Figure 12: Schottky Forward Characteristics

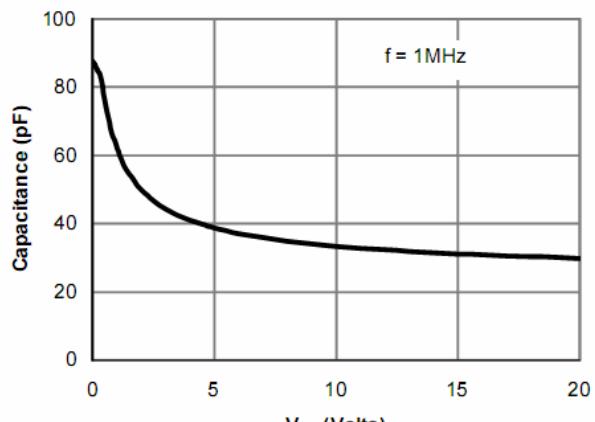


Figure 13: Schottky Capacitance Characteristics

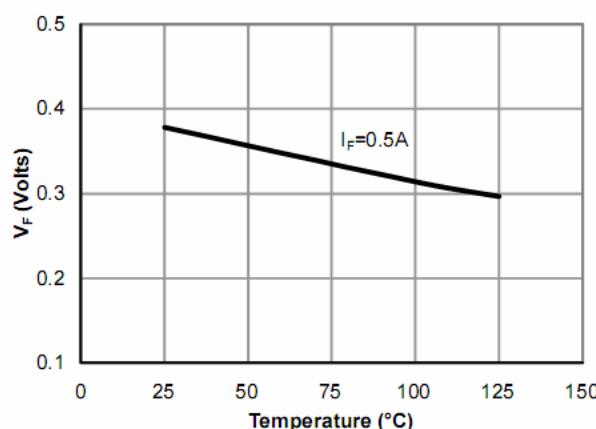


Figure 14: Schottky Forward Drop vs. Junction Temperature

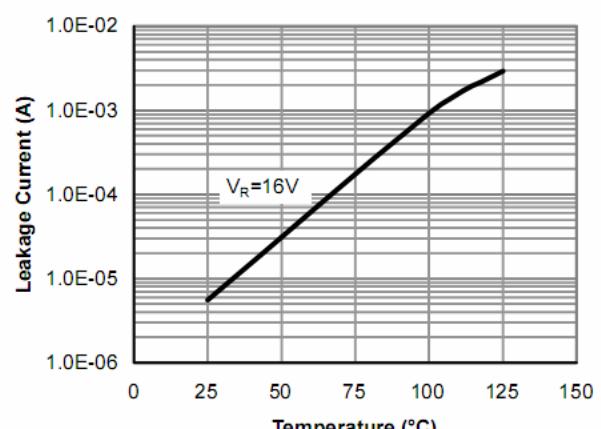


Figure 15: Schottky Leakage current vs. Junction Temperature

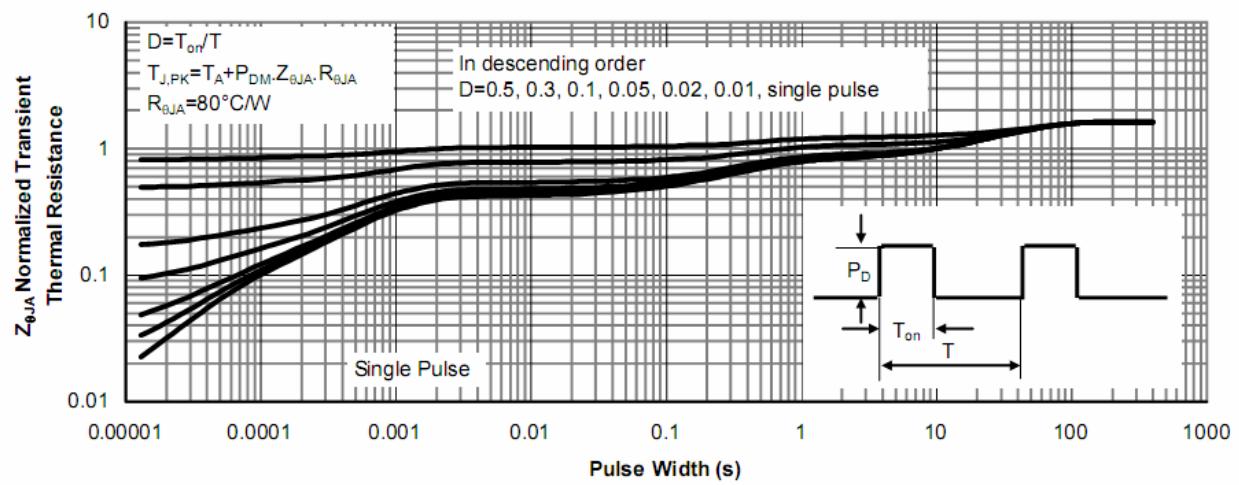
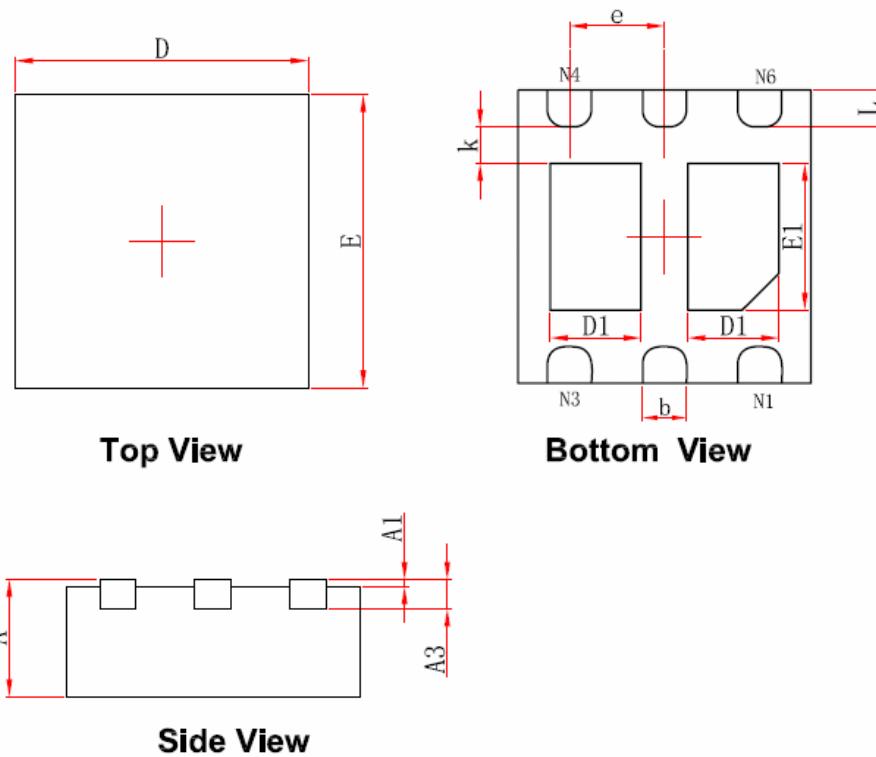


Figure 16: Schottky Normalized Maximum Transient Thermal Impedance

DFNWB2×2-6L-A (P0.65T0.75/0.85) PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700/0.800	0.800/0.900	0.028/0.031	0.031/0.035
A1	0.000	0.050	0.000	0.002
A3	0.203REF.		0.008REF.	
D	1.924	2.076	0.076	0.082
E	1.924	2.076	0.076	0.082
D1	0.520	0.720	0.020	0.028
E1	0.900	1.100	0.035	0.043
k	0.200MIN.		0.008MIN.	
b	0.250	0.350	0.010	0.014
e	0.650TYP.		0.026TYP.	
L	0.174	0.326	0.007	0.013

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